

CORRECTION

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Correction: Growth and crystallographic feature-dependent characterization of spinel zinc ferrite thin films by RF sputtering

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Correction

Figure 4g in the original version of this article [1] was misused in the typesetting process. The figure 4g is the same as figure 4a. The corrected image for figure 4g is shown here (Figure 1).

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Reference

1. Liang YC, Hsia HY: Growth and crystallographic feature-dependent characterization of spinel zinc ferrite thin films by RF sputtering. *Nanoscale Res Lett* 2013, **8**:537.

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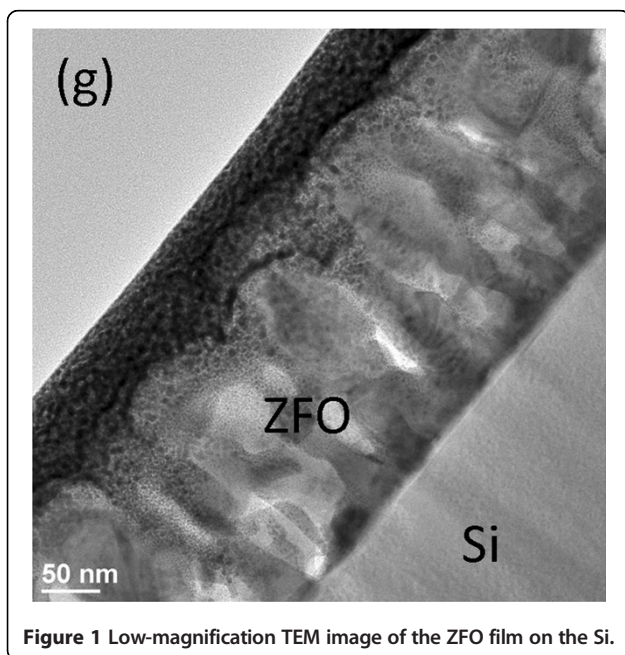


Figure 1 Low-magnification TEM image of the ZFO film on the Si.

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